

Search Notes		Application/Control No.	Applicant(s)/Patent under Reexamination
		10/634,747	SESSER ET AL.
		Examiner	Art Unit
		Dinh Q. Nguyen	3752

SEARCHED			
Class	Subclass	Date	Examiner
239	204		
214.17			
214.19			
214.23			
222.11			
222.15			
222.17			
232			
233			
243			
244			
245			
246			
247	3-21-05	QJ	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST SEARCH ATTACHED REF 09/818, 275 10/119, 294	3-21-05	QJ
UPDATED EAST SEARCH ATTACHED	8-03-05	QJ